Application/Control No. Applicant(s)/Patent Under Reexamination 10/532,849 MIURA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Nguyen T. Ha 2831 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,292,348 09-2001 Lin, Chieh-Fu 361/301.3 Α * US-6,181,543 01-2001 Kobayashi et al. В 361/301.3 * С US-5,587,869 12-1996 Azumi et al. 361/301.3 * US-5,683,834 11-1997 D Fujimoto et al. 429/221 US-Ε US-F US-G US-Н US-١ US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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